Preferred Device

Sensitive Gate Silicon Controlled Rectifiers

Reverse Blocking Thyristors

Designed for high volume, low cost, industrial and consumer applications such as motor control, process control, temperature, light and speed control.

Features

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Surface Mount Lead Form Case 369C
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V
 Machine Model, C > 400 V
- Pb-Free Packages are Available

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (T_J = -40 to 110°C, Sine Wave, 50 to 60 Hz, R_{GK} = 1 kΩ) MCR716 MCR718	V _{DRM,} V _{RRM}	400 600	V
On–State RMS Current (180° Conduction Angles; T _C = 90°C)	I _{T(RMS)}	4.0	Α
Average On–State Current (180° Conduction Angles; T _C = 90°C)	I _{T(AV)}	2.6	Α
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T _J = 110°C)	I _{TSM}	25	Α
Circuit Fusing Consideration (t = 8.3 msec)	l ² t	2.6	A ² sec
Forward Peak Gate Power (Pulse Width \leq 1.0 μ sec, T_C = 90°C)	P _{GM}	0.5	W
Forward Average Gate Power (t = 8.3 msec, T _C = 90°C)	P _{G(AV)}	0.1	W
Forward Peak Gate Current (Pulse Width \leq 1.0 μ sec, $T_C = 90^{\circ}C$)	I _{GM}	0.2	Α
Operating Junction Temperature Range	TJ	-40 to +110	°C
Storage Temperature Range	T _{stg}	-40 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.



ON Semiconductor®

http://onsemi.com

SCRs 4.0 AMPERES RMS 400 – 600 VOLTS





DPAK CASE 369C STYLE 4

MARKING DIAGRAM



PIN ASSIGNMENT			
1	Cathode		
2	Anode		
3	Gate		
4	Anode		

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	3.0	°C/W
Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	80	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	TL	260	°C

Characteristic	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Peak Repetitive Forward or Reverse Blocking Current; F $(V_{AK} = Rated V_{DRM})$ or $V_{RRM})$	$R_{GK} = 1 \text{ k}\Omega \text{ (Note 3)}$ $T_C = 25^{\circ}\text{C}$ $T_C = 110^{\circ}\text{C}$	I _{DRM} I _{RRM}	- -	- -	10 200	μΑ
ON CHARACTERISTICS			- -	-	_	
Peak Reverse Gate Blocking Voltage (I _{GR} = 10 μA)		V_{RGM}	10	12.5	18	V
Peak Reverse Gate Blocking Current (V _{GR} = 10 V)		I _{RGM}	_	-	1.2	μΑ
Peak Forward On-State Voltage (Note 4) (I _{TM} = 5.0 A Peak) (I _{TM} = 8.2 A Peak)		V _{TM}		1.3 1.5	1.5 2.2	V
Gate Trigger Current (Continuous dc) (Note 5) $(V_D = 12 \ Vdc, \ R_L = 30 \ \Omega)$	T _C = 25°C T _C = -40°C	I _{GT}	1.0	25 -	75 300	μΑ
Gate Trigger Voltage (Continuous dc) (Note 5) $(V_D = 12 \text{ Vdc}, R_L = 30 \Omega)$	$T_{C} = 25^{\circ}C$ $T_{C} = -40^{\circ}C$ $T_{C} = 110^{\circ}C$	V _{GT}	0.3 - 0.2	0.55 - -	0.8 1.0 -	V
Holding Current (Note 3) $(V_D = 12 \text{ Vdc, Initiating Current} = 20 \text{ mA, } R_{GK} = 1 \text{ k}\Omega)$	T _C = 25°C T _C = -40°C	l _H	0.4	1.0 -	5.0 10	mA
Latching Current (Note 3) ($R_{GK} = 1 \text{ k}\Omega$) ($V_D = 12 \text{ Vdc}, I_G = 2.0 \text{ mA}, T_C = 25^{\circ}\text{C}$) ($V_D = 12 \text{ Vdc}, I_G = 2.0 \text{ mA}, T_C = -40^{\circ}\text{C}$)		ΙL		- -	5.0 10	mA
Total Turn-On Time (Source Voltage = 12 V, R_S = 6 k Ω , I_T = 8 A(pk), R_{GK} = (V_D = Rated V_{DRM} , Rise Time = 20 ns, Pulse Width =		t _{gt}	-	2.0	5.0	μS
YNAMIC CHARACTERISTICS						
Critical Rate of Rise of Off–State Voltage (V_D = 0.67 x Rated V_{DRM} , R_{GK} = 1 k Ω , Exponential Waveform, T_J = 110°C)		dv/dt	5.0	10	_	V/μs
Repetitive Critical Rate of Rise of On–State Current (f = 60 Hz, I_{PK} = 30 A, PW = 100 μ s, dIG/dt = 1 A/ μ s)		di/dt	-	-	100	A/μs

^{2.} Case 369C, when surface mounted on minimum recommended pad size.

ORDERING INFORMATION

Device	Package	Shipping [†]	
MCR716T4	DPAK		
MCR716T4G	DPAK (Pb-Free)	OFOO / Tong and Deel	
MCR718T4	DPAK	- 2500 / Tape and Reel	
MCR718T4G	DPAK (Pb-Free)	1	

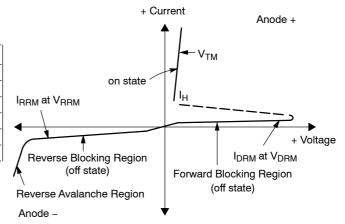
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{3.} Ratings apply for negative gate voltage or $R_{GK} = 1 \text{ k}\Omega$. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.
Pulse Test: Pulse Width ≤ 2 ms, Duty Cycle ≤ 2%.

^{5.} R_{GK} current not included in measurements.

Voltage Current Characteristic of SCR

Symbol	Parameter
V_{DRM}	Peak Repetitive Off-State Forward Voltage
I _{DRM}	Peak Forward Blocking Current
V_{RRM}	Peak Repetitive Off-State Reverse Voltage
I _{RRM}	Peak Reverse Blocking Current
V_{TM}	Peak On-State Voltage
I _H	Holding Current



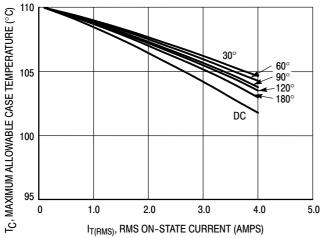


Figure 1. RMS Current Derating

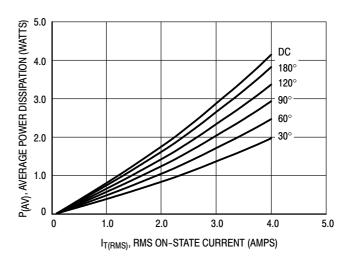


Figure 2. On-State Power Dissipation

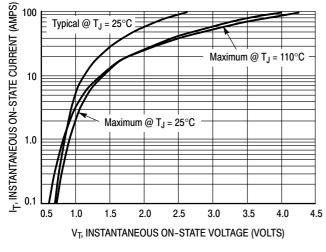


Figure 3. On-State Characteristics

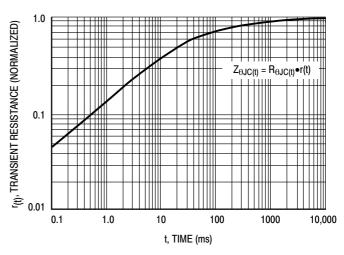


Figure 4. Transient Thermal Response

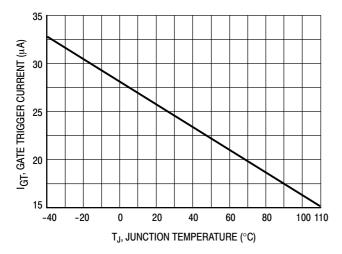


Figure 5. Typical Gate Trigger Current versus Junction Temperature

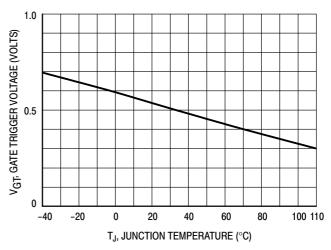


Figure 6. Typical Gate Trigger Voltage versus
Junction Temperature

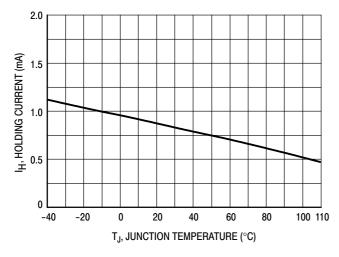


Figure 7. Typical Holding Current versus Junction Temperature

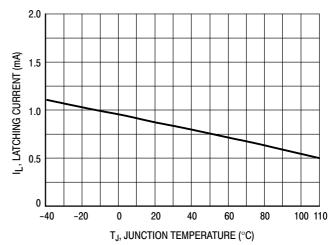
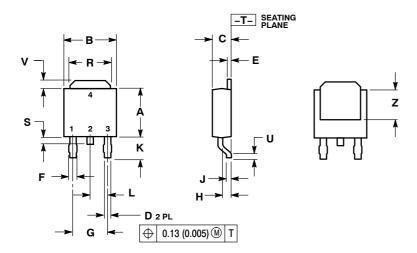


Figure 8. Typical Latching Current versus Junction Temperature

PACKAGE DIMENSIONS

DPAK CASE 369C-01 **ISSUE A**



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

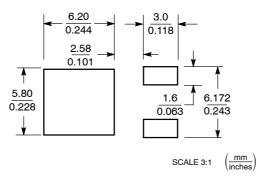
STYLE 4:

PIN 1. CATHODE 2. ANODE

3. GATE

4 ANODE

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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